

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 214503US0	SERIAL NO. 09/964,622		
LIST OF REFERENCES CITED BY APPLICANT <i>DEC 26 2001</i> <i>PTO-1449</i>				APPLICANT Toshiki NANYA, et al.			
				FILING DATE September 28, 2001	GROUP 1756		
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>DR</i>	AA	5,882,832	03/16/99	Tosaka et al.	1		
<i>DR</i>	AB	5,225,303	07/06/93	Tomita et al.	1		
<i>DR</i>	AC	5,168,028	12/01/92	Nanya et al.	1		
<i>DR</i>	AD	5,079,123	01/07/92	Nanya et al.	1		
<i>DR</i>	AE	5,102,766	04/07/92	Nanya et al.	1		
<i>DR</i>	AF	5,085,965	02/04/92	Nanya et al.	1		
<i>DR</i>	AG	4,980,258	12/25/90	Aoki et al.	1		
<i>DR</i>	AH	4,990,425	02/05/91	Nanya et al.	1		
<i>DR</i>	AI	6,303,258	10/16/01	Katoh et al.	1		
<i>DR</i>	AJ	6,183,926	02/06/01	Kuroda et al.	1		
<i>DR</i>	AK	6,103,441	08/15/00	Tomita et al.	1		
<i>DR</i>	AL	6,074,794	06/13/00	Fushimi et al.	1		
<i>DR</i>	AM	6,004,715	12/21/99	Suzuki et al.	1		
<i>DR</i>	AN	5,879,849	03/09/99	Sawada et al.	1		
FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES	NO	
<i>DR</i>	AO	63-088564	04/19/88	JAPAN w/English Abstract			
<i>DR</i>	AP	63-184762	07/03/88	JAPAN w/English Abstract			
<i>DR</i>	AQ	03-056974	03/12/91	JAPAN w/English Abstract			
<i>DR</i>	AR	06-230609	08/19/94	JAPAN w/English Abstract			
<i>DR</i>	AS	08-030017	02/02/96	JAPAN w/English Abstract			
<i>DR</i>	AT	09-171271	06/30/97	JAPAN w/English Abstract			
<i>DR</i>	AU	09-211896	08/15/97	JAPAN w/English Abstract			
<i>DR</i>	AV	11-218965	08/10/99	JAPAN w/English Abstract			
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
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						<input type="checkbox"/> Additional References sheet(s) attached	
Examiner <i>DR</i>						Date Considered <i>10/19/02</i>	
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							

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		FILING DATE September 28, 2001		GROUP <i>1756</i>			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>SO</i>	AA	5,851,716	12/22/98	Kuramoto et al.			
<i>SO</i>	AB	5,061,588	10/29/91	Fushimi et al.			
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Examiner <i>DRD</i>		Date Considered <i>10/29/02</i>					

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LIST OF REFERENCES CITED BY APPLICANT <i>MAY 22 2002</i>		APPLICANT		RECEIVED <i>MAY 22 2002</i>	
		FILING DATE September 28, 2001		GROUP TC 1700	
U.S. PATENT DOCUMENTS					
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
CDR	AA 5,288,577	2-22-1994	Yamaguchi et al.		
CDR	AB 5,368,972	11-29-1994	Yamashita et al.		
CDR	AC 5,429,901	7-4-1995	Muto et al.		
CDR	AD 6,010,814	1-4-2000	Kotsugai et al.		
CDR	AE 6,180,298	1-30-01	Kuroda et al.		
CDR	AF 6,074,795	6-13-2000	Watanabe et al.		
CDR	AG 6,228,550	5-8-2001	Matsuda et al.		
CDR	AH 6,258,502	7-10-2001	Nakamura et al.		
CDR	AI 6,303,257	10-16-2001	Hasegawa et al.		
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FOREIGN PATENT DOCUMENTS					
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Examiner <i>CDR</i>	Date Considered <i>10/28/02</i>				
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LIST OF REFERENCES CITED BY APPLICANT <i>AUG 02 2002</i> <i>JC34</i>		APPLICANT		Toshiki NANYA, et al.	
		FILING DATE 09/28/01		GROUP <i>1752</i> <i>1752</i>	
U.S. PATENT DOCUMENTS					
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS
DR	AA 5,597,673	01/28/97	WATANABE, et al.		
AB					
AC					
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FOREIGN PATENT DOCUMENTS					
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OCT 02 2002

SHEET 1 OF 1

Form PTO 1449
(Modified)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICE
TRADEMARK

LIST OF REFERENCES CITED BY APPLICANT

ATTY DOCKET NO.

214503US0

SERIAL NO.

09/964,622

APPLICANT

Toshiki NANYA, et al.

FILING DATE

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U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
CR	AA	5,840,456	11/24/98	TOMITA, et al.			
CR	AB	5,721,083	02/24/98	MASUDA, et al.			
CR	AC	5,554,478	09/10/96	KURAMOTO, et al.			
CR	AD	5,403,690	04/04/95	KURAMOTO, et al.			
CR	AE	5,344,732	09/06/94	CHIBA, et al.			
CR	AF	4,933,250	06/12/90	NAKAYAMA, et al.			
CR	AG	4,950,573	08/21/90	YAMAGUCHI, et al.			
CR	AH	4,762,763	08/09/88	NOMURA, et al.			
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		FILING DATE 09/28/01	GROUP 1752 1752

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EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
GD	AA	6,406,826	06/18/02	SUZUKI, et al.			
CR	AB	6,363,229	03/26/02	SHIRAISHI, et al.			
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Examiner CRDate Considered 11/4/02

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